## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: OZIN et al.

Appl. No. :

Filed: September 12, 2003

Title : METHOD OF SELF-ASSEMBLY AND OPTICAL APPLICATIONS

OF CRYSTALLINE COLLOIDAL PATTERNS ON SUBSTRATES

Grp./A.U. :
Examiner :

Docket No.: 14432DIV

Honorable Assistant Commissioner of Patents

Alexandria, VA 22313-1450

Sir:

PTO CUSTOMER NO. 000293

## INFORMATION DISCLOSURE STATEMENT

Submitted herewith is a copy of an Information Disclosure Statement and listing of references which have been filed by applicants in parent applications Serial No. 09/977,254. Copies of the documents referenced may be found in the parent application file.

Respectfully submitted,

Ralph A. Dowell

Registration No. 26,868

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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

Ozin et al. 09/977,254

Appl. No. Filed

10/16/2001

Title

METHOD OF SELF-ASSEMBLY AND OPTICAL

APPLICATIONS OF CRYSTALLINE COLLOIDAL PATTERNS

ON SUBSTRATES

Grp./A.U.

1772

Examiner

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Docket No.

13786

Honorable Assistant Commissioner of Patents Washington, D.C. 20231

Sir:

## INFORMATION DISCLOSURE STATEMENT

In accordance with 37 C.F.R., §§ 1.97-1.99, applicant submits the following information which may be of interest to the examiner in charge of the above referenced application for patent. Copies of the references listed on the attached Form PTO-1449, List of Prior Art Cited by Applicant, are attached.

Also being submitted herewith is a copy of the <u>European Patent</u>

Office Search Report with respect to <u>PCT/CA01/01436</u> which shows the relevancy of the listed patent which are also being submitted.

Respectfully submitted,

Ralph A. Dowell

Registration No. 26,868 Date: August 9, 2002

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	AH		Gates, B. et al: "Self-Assembly of Meso-and Nanoparticles into 3-D Ordered Arrays and Its Applications", Organic/Inorganic Hybrid Materials II, San Francisco, CA, April 5-9, 1999, Materials Research Society Symposium Proceedings, vol. 576, April 5, 1999, pgs. 149-154, XP-000897904.														
	AI		Aizenberg et al.: "Patterned Colloidal Deposition Controlled by Electrostatic and Capillary Forces", Physical Review Letters, vol. 84, no. 13, March 27, 2000, pgs. 2997-3000, XP-001074766.														
	N		Chen, et al.: "Selective Self Organization of Colloids on Patterned Polyelectrolyte Templates", Langmuir, vol. 16, 2000, pgs. 7825-7834, XP-001074759.														
	AK								lead-Based Reag 1074756.	ents within Microf	luidic Sys	stems", /	Anal	. Chem	., vol.		
	AL		in C	Capilla		Adva	inced	Mate	rials, VCH Verlag	allization of Polym sgesellschaft, We							
	AM									rial for All Length 14, July 19, 2000							

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 602; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Vac. Sci. Technol., B 6(1), Jan./Feb. 1988, pgs. 333-336.

DATE CONSIDERED

Deckman H.W. et al.: "Macromolecular Self-Organized Assemblies", American Vacuum Society, J.

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	AU	Yang et al.: "Hierarchically Ordered Oxides", Science, vol. 282, December 18, 1998, 2244-2246.										, pgs.				
	AV	Lin ( Phy	Lin et al.: "Entropically Driven Colloidal Crystallization on Patterned Surfaces", The Americ Physical Society, Physical Review Letters, vol. 85, no. 8, August 21, 2000, pgs. 1770-1773										merica	n		
	AW	Hayward et al.: "Electrophoretic Assembly of Colloidal Crystals with Optically Tunable Micropatterns", Macmillian Magazines Ltd., Nature, vol. 404, March 2, 2000, pgs. 56-58.  Chen et al.: "Selective Self-Organization of Colloids on Patterned Polyelectrolyte Template Langmiur, vol. 16, no. 20, 2000 American Chemical Society, September 8, 2000, pgs. 7825										^				
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	Bi	 	Jiang et al.: "Single-Crystal Colloidal Multilayers of Controlled Thickness", American Chemical Society, Chem. Mater., vol. 11, 1999, pgs. 2132-2140.													
	BJ		Jiang et al.: "The Fabrication and Bandgap Engineering of Photonic Multilayers", Advanced Materials, vol. 13, No. 6, March 16, 2001, pgs. 389-393.													
	ВК		Park et al.: "Crystallization of Mesoscale Particles Over Large Areas", Advanced Materials, vol. 10, no. 13, 1998, pgs. 1028-1031.													
	BL		Blaaderen et al.: "Template-directed Colloidal Crystallization", Nature, vol. 385, January 23, 1997, pgs. 321-324.													
	ВМ		Dimitrov et al.: "Continuous Convective Assembling of Fine Particles into Two-Dimensional Arrays on Solid Surfaces", Langmuir, vol. 12, 1996, pgs. 1303-1311.											rays		
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